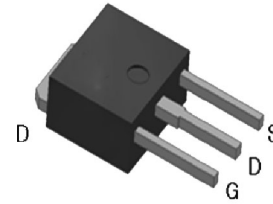
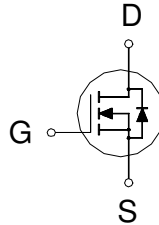


N-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

BV _{DSS}	80V
R _{DS(on)} (MAX.)	65mΩ
I _D	15A



UIS, 100% Tested

Pb-Free Lead Plating & Halogen Free



ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNIT
Gate-Source Voltage		V _{GS}	±20	V
Continuous Drain Current	T _C = 25 °C	I _D	15	A
	T _C = 100 °C		10	
Pulsed Drain Current ¹		I _{DM}	60	
Avalanche Current		I _{AS}	23	
Avalanche Energy	L = 0.1mH, I _D =23A, R _G =25Ω	E _{AS}	27	mJ
Repetitive Avalanche Energy ²	L = 0.05mH	E _{AR}	13	
Power Dissipation	T _C = 25 °C	P _D	39	W
	T _C = 100 °C		15	
Operating Junction & Storage Temperature Range		T _J , T _{stg}	-55 to 150	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNIT
Junction-to-Case	R _{θJC}		3.2	°C / W
Junction-to-Ambient ³	R _{θJA}		50	

¹Pulse width limited by maximum junction temperature.

²Duty cycle ≤ 1%

ELECTRICAL CHARACTERISTICS (T_c = 25 °C, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	80			V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	1.0	1.7	3.0	
Gate-Body Leakage	I _{GSS}	V _{DS} = 0V, V _{GS} = ±20V			±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 64V, V _{GS} = 0V			1	μA
		V _{DS} = 60V, V _{GS} = 0V, T _J = 125 °C			25	
On-State Drain Current ¹	I _{D(ON)}	V _{DS} = 5V, V _{GS} = 10V	15			A
Drain-Source On-State Resistance ¹	R _{DS(ON)}	V _{GS} = 10V, I _D = 15A		55	65	mΩ
		V _{GS} = 5V, I _D = 10A		68	85	
Forward Transconductance ¹	g _{fs}	V _{DS} = 5V, I _D = 15A		12		S
DYNAMIC						
Input Capacitance	C _{iss}	V _{GS} = 0V, V _{DS} = 30V, f = 1MHz		1110		pF
Output Capacitance	C _{oss}			60		
Reverse Transfer Capacitance	C _{rss}			51		
Total Gate Charge ^{1,2}	Q _g	V _{DS} = 40V, V _{GS} = 10V, I _D = 15A		15		nC
Gate-Source Charge ^{1,2}	Q _{gs}			1.7		
Gate-Drain Charge ^{1,2}	Q _{gd}			4.1		
Turn-On Delay Time ^{1,2}	t _{d(on)}	V _{DS} = 40V, I _D = 1A, V _{GS} = 10V, R _{GS} = 6Ω		10		nS
Rise Time ^{1,2}	t _r			8		
Turn-Off Delay Time ^{1,2}	t _{d(off)}			18		
Fall Time ^{1,2}	t _f			6		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T _C = 25 °C)						
Continuous Current	I _S				15	A
Pulsed Current ³	I _{SM}				60	
Forward Voltage ¹	V _{SD}	I _F = I _S , V _{GS} = 0V			1.3	V
Reverse Recovery Time	t _{rr}	I _F = 10A, dI _F /dt = 100A / μS		120		nS
Reverse Recovery Charge	Q _{rr}			500		nC

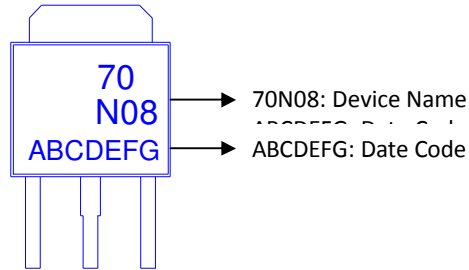
¹Pulse test : Pulse Width ≤ 300 μsec, Duty Cycle ≤ 2%.

²Independent of operating temperature.

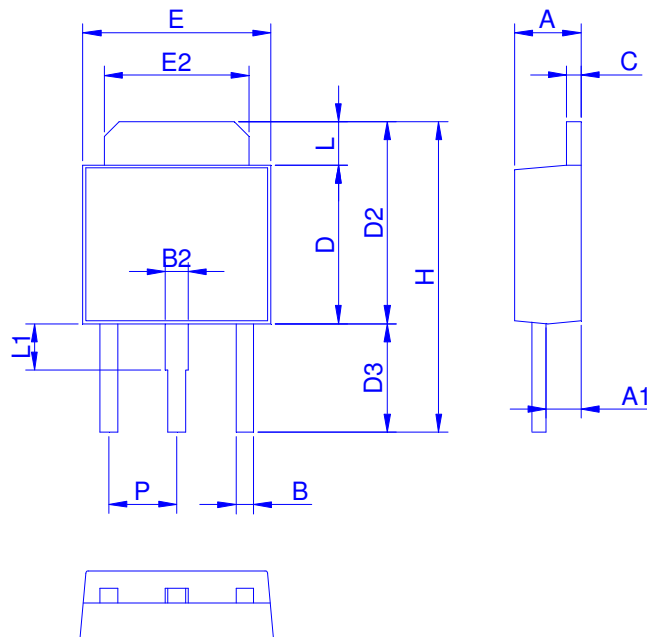
³Pulse width limited by maximum junction temperature.

Ordering & Marking Information:

Device Name: LB70N08E for IPAK (TO-251)



Outline Drawing



Dimension in mm

Dimension	A	A1	B	B2	C	D	D2	D3	E	E2	H	L	L1	P
Min.	2.18	0.89	0.63	0.76	0.46	5.97	6.86	3.2	6.35	4.95	10.06	0.89		
Nom.	2.29		0.76			6.10		3.3	6.60				1.05	2.29
Max.	2.39	1.14	0.85	1.05	0.61	6.22	7.49	3.4	6.73	5.46	10.89	1.27		

TYPICAL CHARACTERISTICS

